

SKCD 09 C 060 I HD



CAL-DIODE

$I_F = 30\text{ A}^{1)}$
 $V_{RRM} = 600\text{ V}$
 Size: $2.95 \times 2.95\text{ mm}^2$

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Features

- high current density
- easy paralleling due to a small forward voltage spread
- very soft recovery behavior
- small switching losses
- high ruggedness
- compatible to thick wire bonding
- compatible to standard solder processes

Typical Applications*

- freewheeling diode for IGBT

Footnotes

¹⁾ Nominal IGBT I_C rating, verified by design and characterization

Absolute Maximum Ratings

Symbol	Conditions	Values	Unit
V_{RRM}	$T_j = 25\text{ °C}$, $I_R = 0.05\text{ mA}$	600	V
I_{FSM}	10 ms $\sin 180^\circ$	$T_j = 25\text{ °C}$ $T_j = 150\text{ °C}$	A A
i^2t	$T_j = 150\text{ °C}$, $t_p = 10\text{ ms}$, $\sin 180^\circ$	128	A^2s
T_{jmax}		175	°C

Electrical Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
$I_{F(AV)}$	$T_c = 80\text{ °C}$, $T_j = 175\text{ °C}$, $F_r = PI/2$, $R_{th(j-c)} = 2.11\text{ K/W}$, Semitrans Assembly		21		A
I_R	$T_j = 25\text{ °C}$, $V_{RRM} = 600\text{ V}$			0.05	mA
	$T_j = 150\text{ °C}$, $V_{RRM} = 600\text{ V}$			4.50	mA
V_F	$T_j = 25\text{ °C}$, $I_F = 13\text{ A}$		1.23	1.48	V
	$T_j = 150\text{ °C}$, $I_F = 13\text{ A}$		1.15	1.34	V
	$T_j = 175\text{ °C}$, $I_F = 13\text{ A}$		1.10	1.26	V
$V_{(TO)}$	$T_j = 150\text{ °C}$		0.80	0.89	V
r_T	$T_j = 150\text{ °C}$		26.92	34.38	$\text{m}\Omega$
$V_{(TO)}$	$T_j = 175\text{ °C}$		0.75	0.83	V
r_T	$T_j = 175\text{ °C}$		26.92	33.31	$\text{m}\Omega$

Dynamic Characteristics

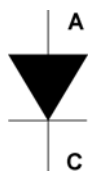
Symbol	Conditions	min.	typ.	max.	Unit
E_{rr}	$T_j = 25\text{ °C}$, 30 A, 300 V, 450 A/ μs		0.06		mJ
E_{rr}	$T_j = 150\text{ °C}$, 30 A, 300 V, 450 A/ μs		0.25		mJ
Q_{rr}	$T_j = 25\text{ °C}$, 30 A, 300 V, 450 A/ μs		1		μC
Q_{rr}	$T_j = 150\text{ °C}$, 30 A, 300 V, 450 A/ μs		2.4		μC
I_{rrm}	$T_j = 25\text{ °C}$, 30 A, 300 V, 450 A/ μs		10		A
I_{rrm}	$T_j = 150\text{ °C}$, 30 A, 300 V, 450 A/ μs		15		A

Thermal Characteristics

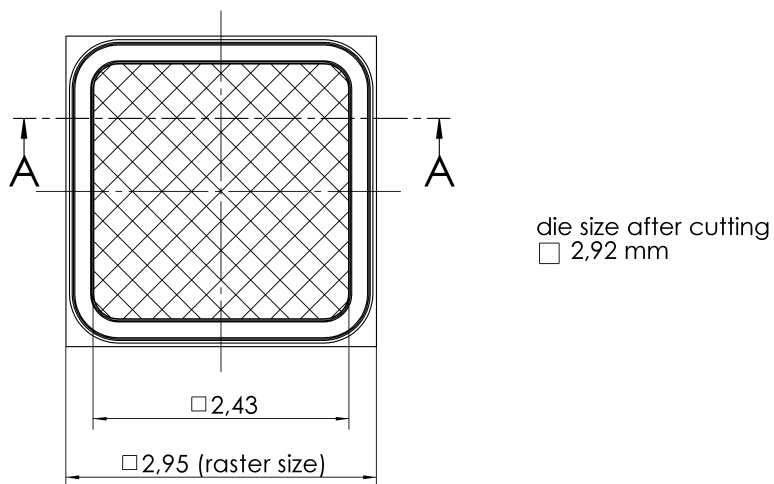
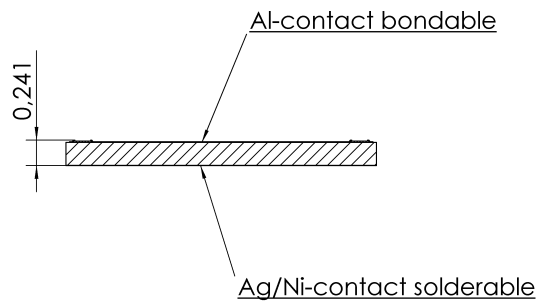
Symbol	Conditions	min.	typ.	max.	Unit
T_j		-40		175	°C
T_{stg}		-40		175	°C
T_{solder}	10 min.			250	°C
T_{solder}	5 min.			320	°C

Mechanical Characteristics

Symbol	Conditions	Values	Unit
Raster size		2.95×2.95	mm^2
Area total		8.7	mm^2
Anode	Metallization	bondable (Al)	
Cathode	Metallization	solderable (Ag/Ni)	
Wire bond		Al, diameter $\leq 500\text{ }\mu\text{m}$	
Chips / Package	150 mm wafer on frame	1758	pcs



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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.